

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/699,300	TAKAGI ET AL.	
		Examiner	Art Unit	Page 1 of 1
		BRIAN P. YENKE	2622	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,965,415	11-2005	Lundblad et al.	348/556
*	B	US-6,947,097	09-2005	Joanblanq, Anne-Fran.cedilla.oise	348/558
*	C	US-6,690,425	02-2004	Worrell, Charles William	348/445
*	D	US-6,369,851	04-2002	Marflak et al.	348/173
*	E	US-6,366,706	04-2002	Weitbruch, Sebastien	382/254
*	F	US-5,748,257	05-1998	Kawabata et al.	348/615
*	G	US-6,323,915	11-2001	Marflak et al.	348/704
*	H	US-5,784,123	07-1998	Yoshimi, Osamu	348/556
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.